Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	52	fragment\$5 same distribut\$4 same (particle rock) same imag\$4	US-PGPUB; USPAT; IBM_TDB	OR	ON.	2005/04/16 12:34
L2	12851	fragment\$5 same distribut\$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/04/16 12:35
L3	1211	L2 same (rock particle)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/04/16 12:35
L4	52	L3 same imag\$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/04/16 12:40
L5	64	(382/109).CCLS.	US-PGPUB; USPAT; IBM_TDB	OR	OFF	2005/04/16 12:48
L6	164	73/152.01	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/04/16 12:48
L7	119	348/85	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/04/16 12:49
L8	451	((356/241.1) or (382/109) or (73/152.01) or (348/85)).CCLS.	US-PGPUB; USPAT; IBM_TDB	OR	OFF	2005/04/16 12:50
L9	43	8 and fragm\$7	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/04/16 12:50
S1	1282	nyberg	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 12:13
S2	18	S1 and estimation	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 12:14
S3	0	estimation same distribution same fragment\$4 same rock	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 12:17
S4	3	(("5844800") or ("6205687") or ("5924575")).PN.	US-PGPUB; USPAT; IBM_TDB	OR	OFF	2005/02/25 12:20
S5	51	fragment\$5 same distribut\$4 same (particle rock) same imag\$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/04/16 12:34
S6	62	(382/109).CCLS.	US-PGPUB; USPAT; IBM_TDB	OR	OFF	2005/02/25 12:27

S7	12599	fragment\$5 same distribut\$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 12:55
S8	1189	S7 same (rock particle)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 12:55
S9	51	S8 same imag\$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/04/16 12:35
S10	0	S9 same correspond\$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 12:56



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			 A segmentation method for multi-connected particle delineation Wu, X.; Kemeny, J.M.; Applications of Computer Vision, Proceedings, 1992., IEEE Workshop on 30 Nov2 Dec. 1992 Page(s):240 - 247
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